Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10553076	YONEMURA ET AL.
Examiner	Art Unit
MEIYA LI	2811

SEARCHED				
Class	Subclass	Date	Examiner	
361	748,750,761,764,783			
257	787,E21.504,E23.004,E23.036,E23.066,E23.092			
174	250,251,258	6/2/08	ML	
	updated	11/19/08	ML	
	updated	2/24/09	ML	
257	678	7/28/09		
174	256,257,260,268	7/28/09	ML	
	updated	10/29/09	ML	

SEARCH NOTES			
Search Notes	Date	Examiner	
EAST	6/1-2/08	ML	
updated	11/19/08	ML	
updated	2/24/09	ML	
Consulted with Ori Nadav	7/27/09		
updated	7/28/09	ML	
updated	10/29/09	ML	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	see attachment	7/28/09	ML
	updated	10/29/09	ML

/M. L./	
Examiner, Art Unit 2811	

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